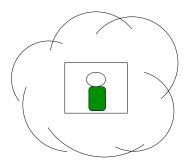
Capacitated Metric Labeling

Ankur Moitra, MIT

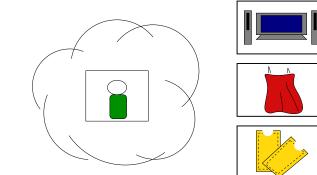
joint work with Matthew Andrews, MohammadTaghi Hajiaghayi and Howard Karloff

January 24, 2011

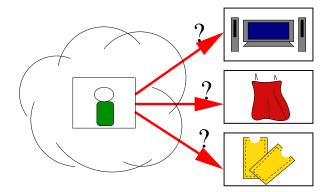
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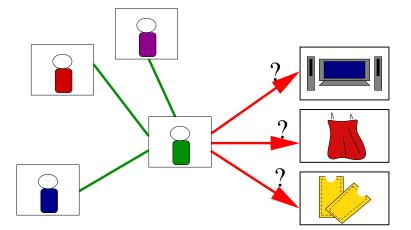


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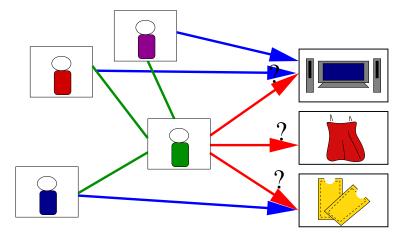


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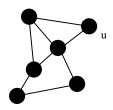


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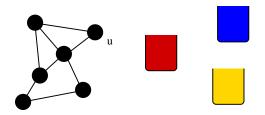
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G = (V, E)

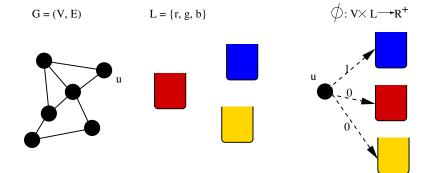


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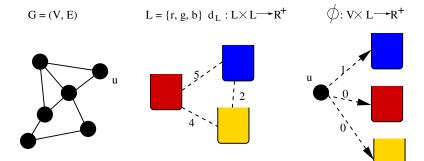




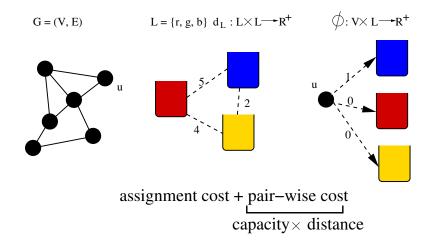
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Metric Labeling Problem: (introduced by Kleinberg and Tardos)

$$\min_{f:V\to L}\sum_{u\in V}\phi(u,f(u))+\sum_{(u,v)\in E}w(u,v)d_L(f(u),f(v))$$

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Applications to classification problems in statistical physics, biometry, machine vision, \ldots

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Also encodes MAP estimation problem for Markov Random Fields

Let |V| = n, |L| = k

Theorem (Kleinberg, Tardos)

There is a polynomial time $O(\log k)$ -approximation algorithm for METRIC LABELING

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For any $\epsilon > 0$, METRIC LABELING is $\Omega(\log^{1/2-\epsilon} k)$ -hard to approximate, unless P = NP

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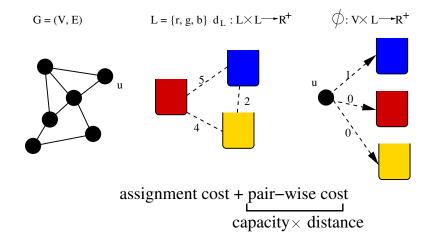
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Problem

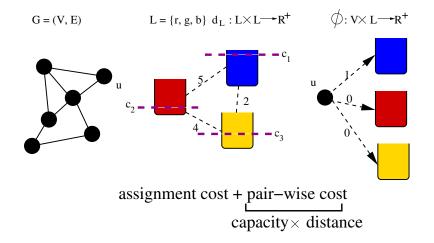
What if an approximation algorithm returns a highly imbalanced (balanced) solution, and our goal is a balanced (imbalanced) solution?

Capacitated Metric Labeling



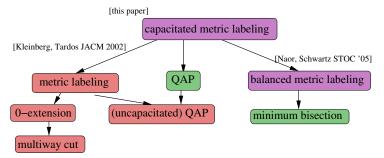
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Capacitated Metric Labeling



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Optimization



Theorem

For k = O(1), there is a polynomial time $O(\log n)$ -approximation algorithm for CAPACITATED METRIC LABELING

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... this is the regime of interest for many classification problems

Congestion

Question

What if |L| is not constant?



Question

What if |L| is not constant?

In this case, determining if there is a ZERO cost solution is HARD



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What if |L| is not constant?

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Definition

The congestion an instance I of CAPACITATED METRIC LABELING is the minimum value of C so that scaling the label capacities up by a factor of C has a zero cost solution

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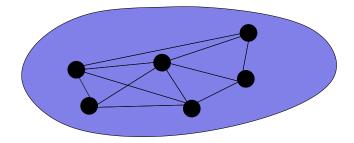
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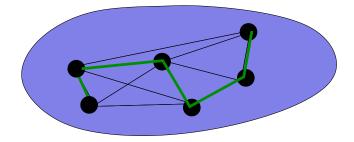
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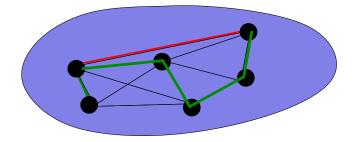
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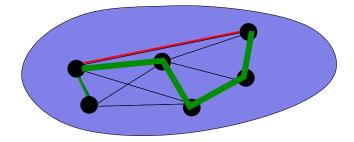
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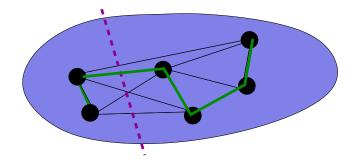
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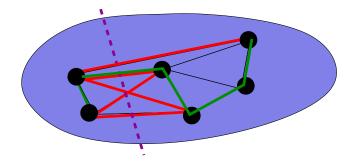
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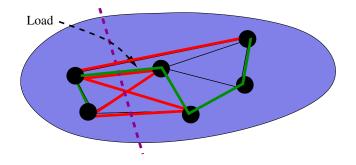
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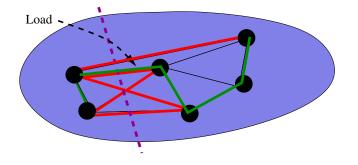
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Hierarchical Decompositions

Theorem (Räcke)

There is a distribution μ on decomposition trees so that for all edges,

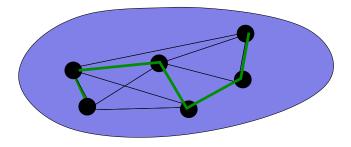
 $E_{T \leftarrow \mu}[load_T(e)] \leq O(\log n)w(e)$



Lemma $COST(f, G) \le COST(f, T)$

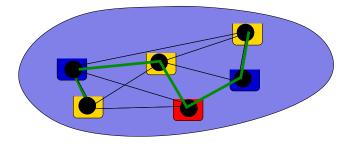
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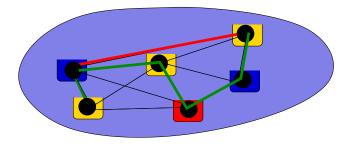
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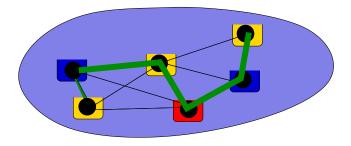
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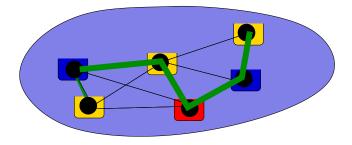
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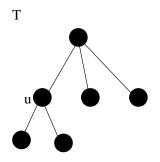
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Lemma

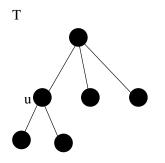
 $COST(f,G) \leq COST(f,T)$ and $E_{T \leftarrow \mu}[COST(f,T)] \leq O(\log n)COST(f,G)$

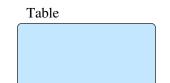


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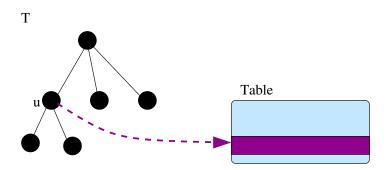


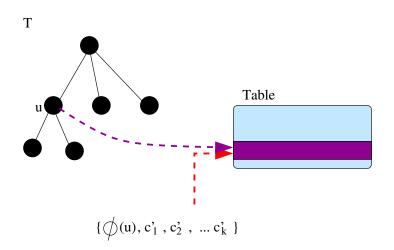






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Our Results

Theorem

For k = O(1), there is a polynomial time $O(\log n)$ -approximation algorithm for CAPACITATED METRIC LABELING

 \ldots this is the regime of interest for many classification problems

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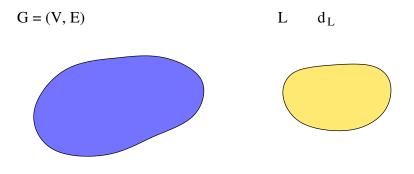
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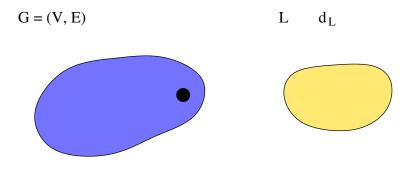
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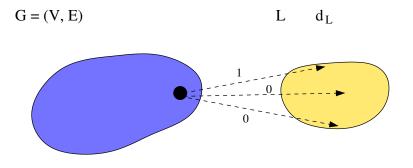
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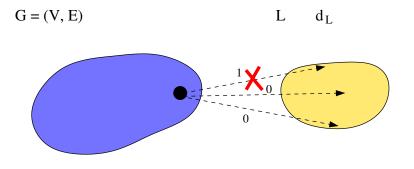
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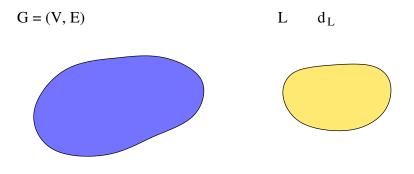
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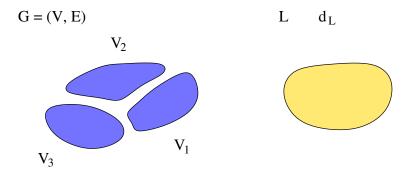
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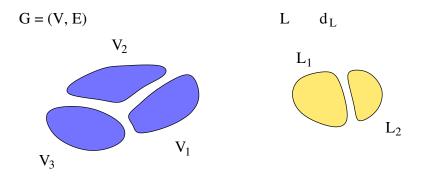
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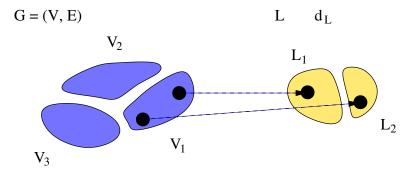
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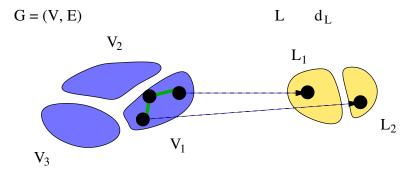
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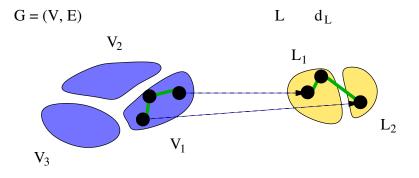
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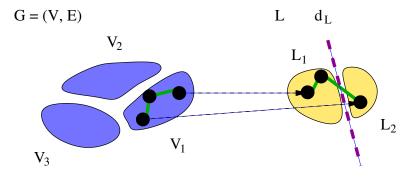
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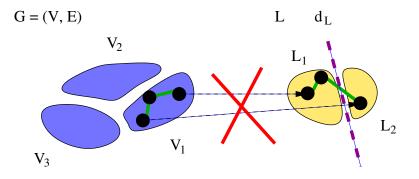
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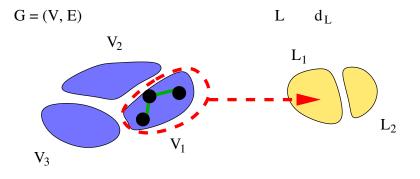
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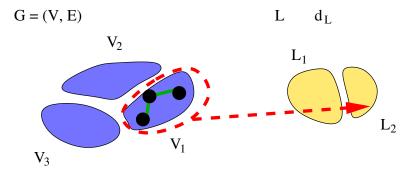
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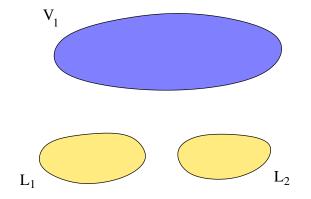
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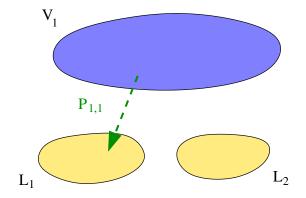
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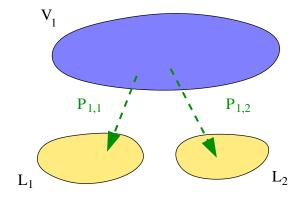
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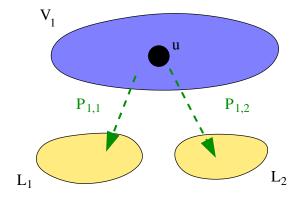
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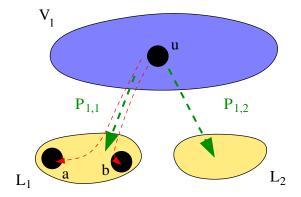
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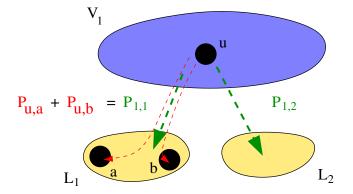
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Two Level Rounding

Procedure

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Procedure

• For each component V_i:

Choose $V_i \rightarrow L_j$ according to $P_{i,j}$

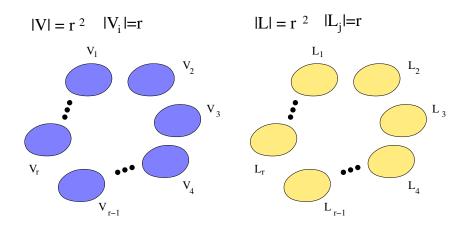
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Procedure

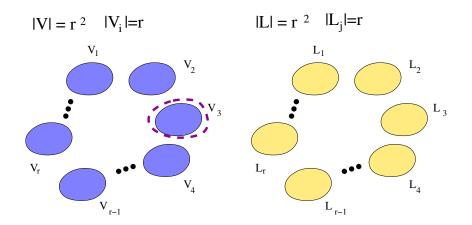
• For each component V_i:

Choose $V_i \rightarrow L_j$ according to $P_{i,j}$ For each component V_i mapped to L_j , for each $u \in V_i$: Choose $u \rightarrow a$ according to $\frac{P_{u,a}}{P_{i,j}}$

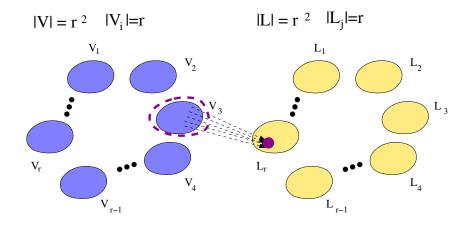
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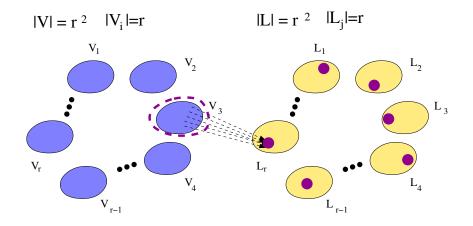
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Planning for Rounding

Expectation:
$$E\Big[|\{u \in V_1 | \gamma(u) = a\}|\Big] = \sum_{u \in V_1} P_{u,a}$$

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Planning for Rounding

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Conditional Expectation: $E\left[|\{u \in V_1 | \gamma(u) = a\}| \middle| V_1 \to L_1\right] = \frac{\sum_{u \in V_1} P_{u,a}}{Pr[V_1 \to L_1]}$

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Observation

In an integral solution the conditional expectation (of $a \in L_1$) is also bounded by the label capacity (of a)

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Let $X_1, X_2, ... X_T$ be the expectation for a label a

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Theorem

There is a polynomial time $O(\log k)$ -approximation algorithm for the congestion of CAPACITATED METRIC LABELING

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Open Questions

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Is there a polynomial time, poly-logarithmic approximation algorithm for CAPACITATED METRIC LABELING *that violates label capacities multiplicatively by O*(log *k*)?

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Open Question

Can the notion of congestion be used to give bi-criteria hardness for other (graph partitioning) problems?

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Questions?

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Thanks!

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